

Description

The AP60P03D uses advanced trench technology to provide excellent $R_{DS(ON)}$, low gate charge and operation with gate voltages as low as 4.5V. This device is suitable for use as a Battery protection or in other Switching application.

General Features

 $V_{DS} = -30V I_{D} = -60A$

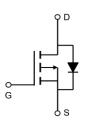
 $R_{DS(ON)}$ <13m Ω @ V_{GS} =-10V (Type: 9m Ω)

Application

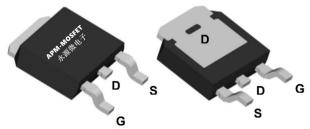
Lithium battery protection

Wireless impact

Mobile phone fast charging







Package Marking and Ordering Information

Product ID	Pack	Marking	Qty(PCS)
AP60P03D	TO-252-3L	AP60P03D XXX YYYY	2500

Absolute Maximum Ratings (TC=25℃unless otherwise noted)

Symbol	Parameter	Rating	Units	
VDS	Drain-Source Voltage	-30	V	
VGS	Gate-Source Voltage	±20	V	
I _D @T _C =25°C	Continuous Drain Current, V _{GS} @ -10V ¹	-60	А	
I _D @T _C =100°C	Continuous Drain Current, V _{GS} @ -10V ¹	-30	А	
IDM	Pulsed Drain Current ²	-150	Α	
EAS	Single Pulse Avalanche Energy ³	125	mJ	
IAS	Avalanche Current	-50	Α	
P _D @T _C =25°C	Total Power Dissipation ⁴	45	W	
TSTG	Storage Temperature Range	-55 to 150	°C	
TJ	Operating Junction Temperature Range	-55 to 150	°C	
R₀JA	Thermal Resistance Junction-Ambient ¹	62	°C/W	
R₀JC	Thermal Resistance Junction-Case ¹	2.8	°C/W	



Electrical Characteristics (T_J=25 °C, unless otherwise noted)

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit	
BVDSS	Drain-Source Breakdown Voltage	V_{GS} =0 V , I_{D} =-250 u A	-30	-32		V	
∆BVDSS/∆TJ	BVDSS Temperature Coefficient	Reference to 25°C , I _D =-1mA		-0.0232		V/°C	
RDS(ON)	Static Drain-Source On-Resistance ²	V _{GS} =-10V , I _D =-30A		9.0	13	mΩ	
		V _{GS} =-4.5V , I _D =-15A		13	18		
VGS(th)	Gate Threshold Voltage	V _{GS} =V _{DS} , I _D =-250uA	-1.2	-1.6	-2.5	V	
$\triangle V_{\text{GS(th)}}$	V _{GS(th)} Temperature Coefficient	VGS-VDS , ID250UA		4.6		mV/°C	
IDSS	Drain Source Leakage Current	V _{DS} =-24V , V _{GS} =0V , T _J =25°C			-1		
IDSS	Drain-Source Leakage Current	V _{DS} =-24V , V _{GS} =0V , T _J =55°C			-5	uA	
IGSS	Gate-Source Leakage Current	V_{GS} =±25 V , V_{DS} =0 V			±100	nA	
gfs	Forward Transconductance	V _{DS} =-5V , I _D =-30A		30		S	
Rg	Gate Resistance	V _{DS} =0V , V _{GS} =0V , f=1MHz		9		Ω	
Qg	Total Gate Charge (-4.5V)			22			
Qgs	Gate-Source Charge	V_{DS} =-15V , V_{GS} =-4.5V , I_{D} =-15A		8.7		nC	
Qgd	Gate-Drain Charge			7.2			
Td(on)	Turn-On Delay Time	\/ - 45\/ \/ - 40\/		8		- ns	
Tr	Rise Time	V_{DD} =-15 V , V_{GS} =-10 V		73.7			
Td(off)	Turn-Off Delay Time	, Ng-5.5 ₅₂ I _D =-15A		61.8			
T _f	Fall Time	ID=-13A		24.4			
Ciss	Input Capacitance			2215			
Coss	Output Capacitance	V_{DS} =-15V , V_{GS} =0V , f=1MHz		310		pF	
Crss	Reverse Transfer Capacitance			237			
IS	Continuous Source Current ^{1,5}	\\ \\ \\ \\ \\ \\ \\ \\ \\ \\ \\ \\ \\			-45	Α	
ISM	Pulsed Source Current ^{2,5}	$V_G=V_D=0V$, Force Current			-150	Α	
VSD	Diode Forward Voltage ²	V _{GS} =0V , I _S =-1A , T _J =25°C			-1	V	
trr	Reverse Recovery Time	IF=-15A , dI/dt=100A/μs ,		19		nS	
Q _{rr}	Reverse Recovery Charge	T _J =25°C		9		nC	

Note:

- 1. The data tested by surface mounted on a 1 inch 2 FR-4 board with 2OZ copper.
- 2_{\times} The data tested by pulsed , pulse width \leqq 300us , duty cycle \leqq 2%
- 3. The EAS data shows Max. rating . The test condition is VDD=-25V,VGS=-10V,L=0.1mH,IAS=-50A
- 4. The power dissipation is limited by 150 ℃ junction temperature
- 5. The data is theoretically the same as ID and IDM, in real applications, should be limited by total power dissipation.



Typical Characteristics

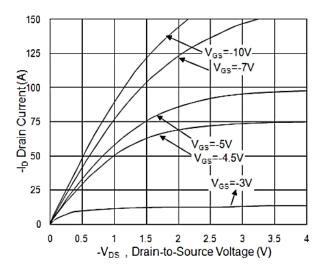


Fig.1 Typical Output Characteristics

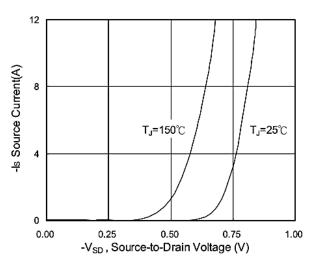


Fig.3 Forward Characteristics of Reverse

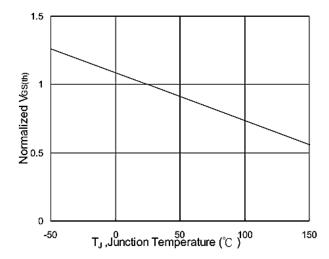


Fig.5 Normalized V_{GS(th)} vs. T_J

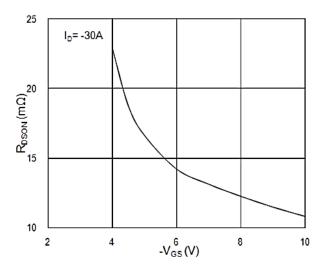


Fig.2 On-Resistance vs. G-S Voltage

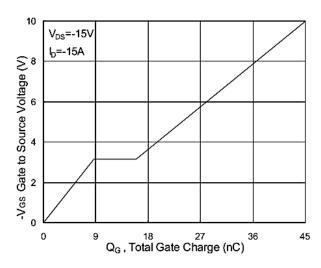


Fig.4 Gate-charge Characteristics

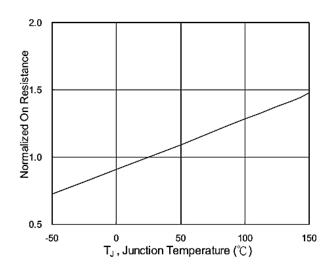
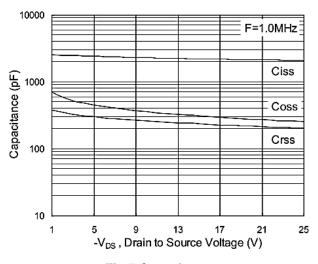


Fig.6 Normalized RDSON vs. TJ







1000

100

100

100

100us

100us

100us

100ms

100ms

100ms

DC

1

T_c=25'C

Single Pulse

0

0.1

1

-V_{DS} (V)

10

100

Fig.7 Capacitance

Fig.8 Safe Operating Area

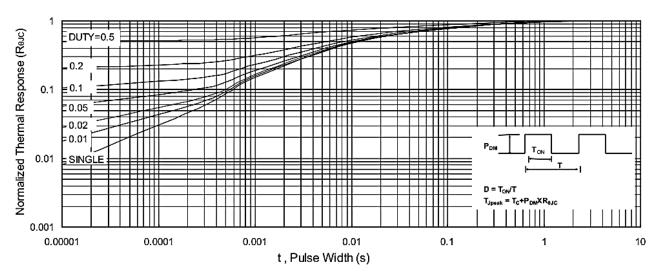


Fig.9 Normalized Maximum Transient Thermal Impedance

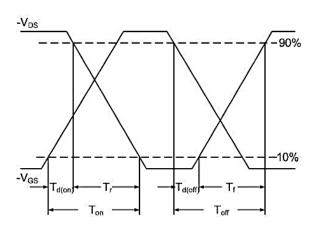


Fig.10 Switching Time Waveform

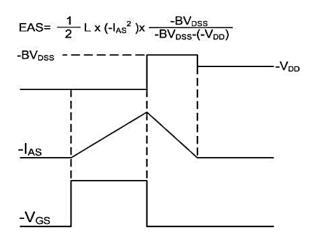
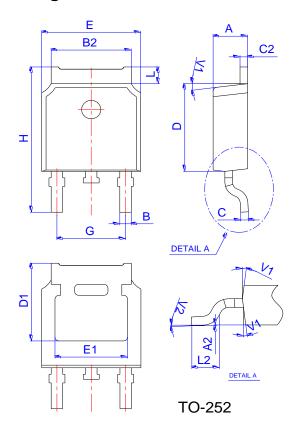


Fig.11 Unclamped Inductive Switching Waveform

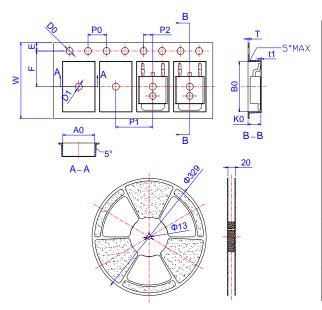


Package Mechanical Data:TO-252-3L



	Dimensions						
Ref.	tef. M		Millimeters		Inches		
	Min.	Тур.	Max.	Min.	Тур.	Max.	
Α	2.10		2.50	0.083		0.098	
A2	0		0.10	0		0.004	
В	0.66		0.86	0.026		0.034	
B2	5.18		5.48	0.202		0.216	
С	0.40		0.60	0.016		0.024	
C2	0.44		0.58	0.017		0.023	
D	5.90		6.30	0.232		0.248	
D1	5.30REF			0.209REF			
E	6.40		6.80	0.252		0.268	
E1	4.63			0.182			
G	4.47		4.67	0.176		0.184	
Н	9.50		10.70	0.374		0.421	
L	1.09		1.21	0.043		0.048	
L2	1.35		1.65	0.053		0.065	
V1		7°			7°		
V2	0°		6°	0°		6°	

Reel Spectification-TO-252



	Dimensions					
Ref.	Millimeters			Inches		
	Min.	Тур.	Max.	Min.	Тур.	Max.
W	15.90	16.00	16.10	0.626	0.630	0.634
E	1.65	1.75	1.85	0.065	0.069	0.073
F	7.40	7.50	7.60	0.291	0.295	0.299
D0	1.40	1.50	1.60	0.055	0.059	0.063
D1	1.40	1.50	1.60	0.055	0.059	0.063
P0	3.90	4.00	4.10	0.154	0.157	0.161
P1	7.90	8.00	8.10	0.311	0.315	0.319
P2	1.90	2.00	2.10	0.075	0.079	0.083
A0	6.85	6.90	7.00	0.270	0.271	0.276
В0	10.45	10.50	10.60	0.411	0.413	0.417
K0	2.68	2.78	2.88	0.105	0.109	0.113
Т	0.24		0.27	0.009		0.011
t1	0.10			0.004		
10P0	39.80	40.00	40.20	1.567	1.575	1.583



Attention

- 1,Any and all APM Microelectronics products described or contained herein do not have specifications that can handle applications that require extremely high levels of reliability, such as life support systems, aircraft's control systems, or other applications whose failure can be reasonably expected to result in serious physical and/or material damage. Consult with your APM Microelectronics representative nearest you before using any APM Microelectronics products described or contained herein in such applications.
- 2,APM Microelectronics assumes no responsibility for equipment failures that result from using products at values that exceed, even momentarily, rated values (such as maximum ratings, operating condition ranges, or other parameters) listed in products specifications of any and all APM Microelectronics products described or contained herein.
- 3, Specifications of any and all APM Microelectronics products described or contained here instipulate the performance, characteristics, and functions of the described products in the independent state, and are not guarantees of the performance, characteristics, and functions of the described products as mounted in the customer's products or equipment. To verify symptoms and states that cannot be evaluated in an independent device, the customer should always evaluate and test devices mounted in the customer's products or equipment.
- 4, APM Microelectronics Semiconductor CO., LTD. strives to supply high quality high reliability products. However, any and all semiconductor products fail with some probability. It is possible that these probabilistic failures could give rise to accidents or events that could endanger human lives that could give rise to smoke or fire, or that could cause damage to other property. Whendesigning equipment, adopt safety measures so that these kinds of accidents or events cannot occur. Such measures include but are not limited to protective circuits and error prevention circuits for safe design, redundant design, and structural design.
- 5,In the event that any or all APM Microelectronics products (including technical data, services) described or contained herein are controlled under any of applicable local export control laws and regulations, such products must not be exported without obtaining the export license from the authorities concerned in accordance with the above law.
- 6, No part of this publication may be reproduced or transmitted in any form or by any means, electronic or mechanical, including photocopying and recording, or any information storage or retrieval system, or otherwise, without the prior written permission of APM Microelectronics Semiconductor CO., LTD.
- 7, Information (including circuit diagrams and circuit parameters) herein is for example only; it is not guaranteed for volume production. APM Microelectronics believes information herein is accurate and reliable, but no guarantees are made or implied regarding its use or any infringements of intellectual property rights or other rights of third parties.
- 8, Any and all information described or contained herein are subject to change without notice due to product/technology improvement, etc. When designing equipment, refer to the "Delivery Specification" for the APM Microelectronics product that you Intend to use.







Edition	Date	Change
Rve3.0	2020/7/31	Initial release
Rve3.1	2021/9/23	Change of specification format

Copyright Attribution"APM-Microelectronice"